

<b>Notice of References Cited</b>	Application/Control No. 10/565,663		Applicant(s)/Patent Under Reexamination KAMPERMAN ET AL.	
	Examiner Richard G. Keehn		Art Unit 2152	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0157002 A1	10-2002	Messerges et al.	713/155
*	B	US-2004/0083306 A1	04-2004	Gloe, Christopher Thomas	709/245
*	C	US-2003/0177376 A1	09-2003	Arce Velleggia et al.	713/189
*	D	US-2003/0144894 A1	07-2003	Robertson et al.	705/8
*	E	US-2002/0062451 A1	05-2002	Scheidt et al.	713/201
*	F	US-2002/0040439 A1	04-2002	Kellum, Charles W.	713/200
*	G	US-2002/0031230 A1	03-2002	Sweet et al.	380/278
*	H	US-2001/0039624 A1	11-2001	Kellum, Charles W.	713/201
*	I	US-7,194,543 B2	03-2007	Robertson et al.	709/226
*	J	US-6,880,007 B1	04-2005	Gardos et al.	709/225
*	K	US-6,463,534 B1	10-2002	Geiger et al.	713/168
*	L	US-6,460,023 B1	10-2002	Bean et al.	705/54
*	M	US-6,223,291 B1	04-2001	Puhl et al.	726/28

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.